## Application/Control No. Applicant(s)/Patent Under Reexamination 10/034,057 LIU ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Bob A. Phunkulh 2616

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0136298	09-2002	Anantharamu et al.	375/240.12
	В	US-			
	С	US-			
	D	US-			
	E	US-			
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## FOREIGN PATENT DOCUMENTS

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## **NON-PATENT DOCUMENTS**

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